

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10692537	KLUWE, LAN
	<b>Examiner</b>	<b>Art Unit</b>
	Young J Kim	1637

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
searched patent databases (USPT, USPPG, EPO, JPO, DERWENT, IBM-TDB)	3/4/2008	YJK
see enclosed for text-search strategy	3/4/2008	YJK

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>